## Search Notes



	Applicant(s)/Patent Under Reexamination
10551039	FUJITA ET AL.

Examiner Art Unit
NIKHIL SRIRAMAN 3664

SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES		
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Consulted with Marc McDieunel	12/20/2008	
Assignee search on East, Inventor search on eDan		
NPL, including IEEE databases searched (see attached history)		

INTERFERENCE SEARCH			
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